

STW13NK100Z

N-channel 1000V - 0.56 Ω - 13A - TO-247 Zener - Protected SuperMESHTM PowerMOSFET

General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D	P _W
STW13NK100Z	1000 V	< 0.70 Ω	13 A	350W

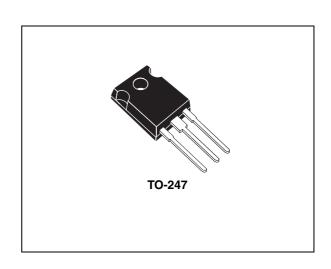
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatibility



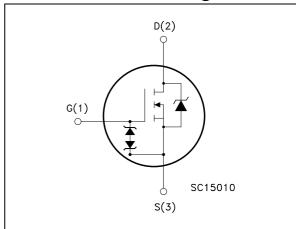
The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STW13NK100Z	W13NK100Z	TO-247	Tube

Contents STW13NK100Z

Contents

1	Electrical ratings
	1.1 Protection features of gate-to-source zener diodes
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuit
4	Package mechanical data
5	Revision history

STW13NK100Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	1000	V
V _{DGR}	Drain-gate voltage (R _{GS} = 20KΩ)	1000	V
V _{GS}	Gate-source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25°C	13	Α
I _D	Drain current (continuous) at T _C =100°C	8.2	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	52	Α
P _{TOT}	Total dissipation at T _C = 25°C	350	W
	Derating Factor	2.7	W/°C
V _{ESD (G-S)}	Gate source ESD(HBM-C=100pF, R=1,5KΩ)	6000	V
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4	V/ns
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

^{1.} Pulse width limited by safe operating area

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case Max	0.36	°C/W
R _{thj-a}	Thermal resistance junction-ambient Max	50	°C/W
T _I	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max)	13	Α
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=lar, Vdd=50V)	700	mJ

^{2.} $I_{SD} \le 8.3 \text{ A}$, di/dt $\le 200 \text{A/}\mu\text{s}$, $V_{DD} \le V_{(BR)DSS}$, $T_j \le T_{JMAX}$

Electrical ratings STW13NK100Z

Table 4. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV_{GSO}	Gate-source breakdown voltage	Igs=± 1mA (Open Drain)	30			V

1.1 Protection features of gate-to-source zener diodes

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1mA, V _{GS} = 0	1000			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating, V_{DS} = Max rating, $Tc = 125^{\circ}C$			1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{GS} = 0)	V _{GS} = ± 20V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$	3	3.75	4.5	٧
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 6.5 A$		0.56	0.70	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V, I_D = 6.5 A$		14		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		6000 455 100		pF pF pF
C _{osseq} (2)	Equivalent output capacitance	V _{GS} =0, V _{DS} =0V to 800V		227		pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Off-voltage rise time Fall time	V_{DD} =500 V, I_D = 7A, R_G =4.7 Ω , V_{GS} =10V (see <i>Figure 16</i>)		45 35 145 45		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =800V, I_{D} = 13A V_{GS} =10V		190 30 100	266	nC nC nC

^{1.} Pulsed: pulse duration=300 μ s, duty cycle 1.5%

^{2.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Electrical characteristics STW13NK100Z

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				13	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				52	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =8.3A, V _{GS} =0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =13 A, di/dt = 100A/μs, V _{DD} =100 V, Tj=25°C (see <i>Figure 18</i>)		820 12.7 31		ns μC Α
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge $I_{SD}=13 \text{ A},$ $di/dt = 100 \text{A}/\mu \text{s},$ $V_{DD}=100 \text{V. Ti=150 °C}$		1050 17.8 34		ns μC Α	

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

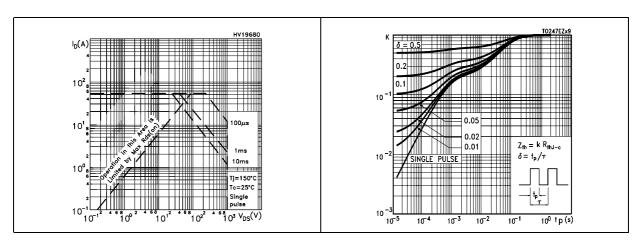
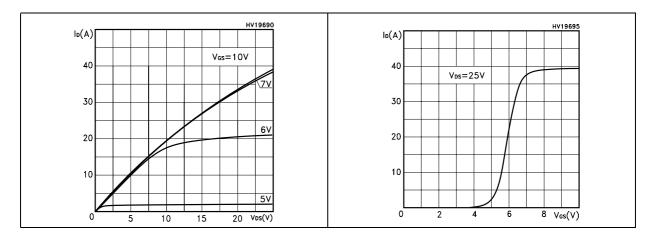


Figure 3. Output characterisics

Figure 4. Transfer characteristics



Electrical characteristics STW13NK100Z

Figure 5. Transconductance

Figure 6. Static drain-source on resistance

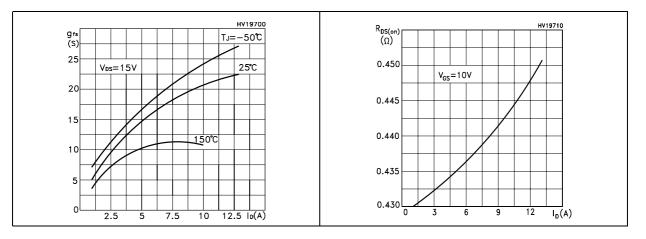


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

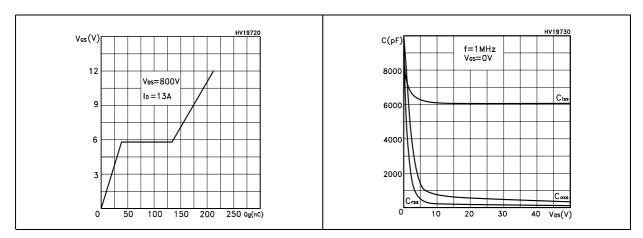
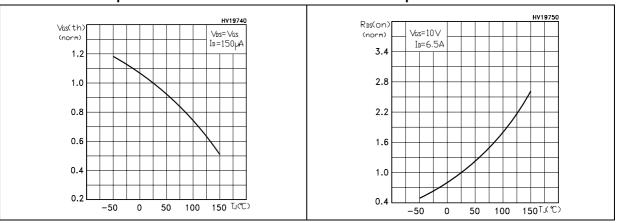


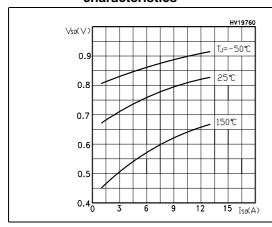
Figure 9. Normalized gate threshold voltage Figure 10. Normalized on resistance vs vs temperature temperature



8/14

Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized B_{VDSS} vs temperature



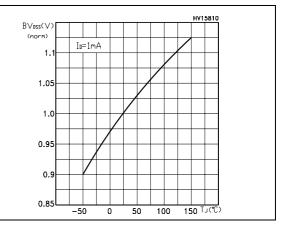
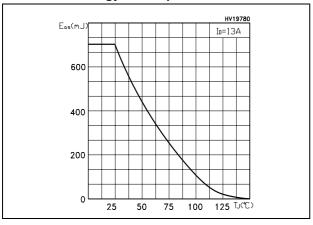


Figure 13. Maximum avalanche energy vs temperature



Test circuit STW13NK100Z

3 Test circuit

Figure 14. Unclamped Inductive load test circuit

Figure 15. Unclamped Inductive waveform

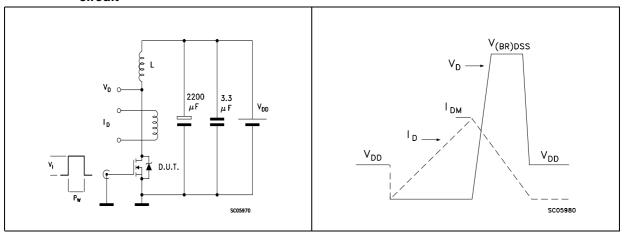


Figure 16. Switching times test circuit for resistive load

Figure 17. Gate charge test circuit

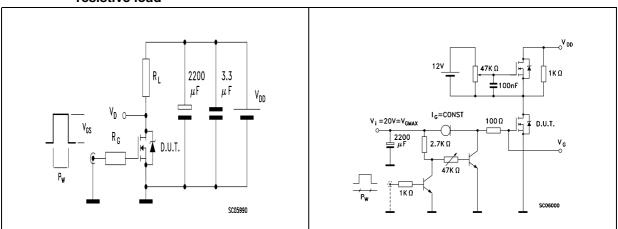
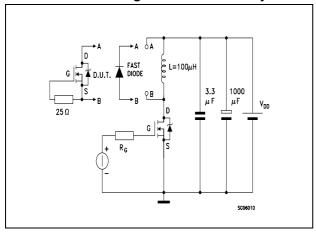


Figure 18. Test circuit for inductive load switching and diode recovery times



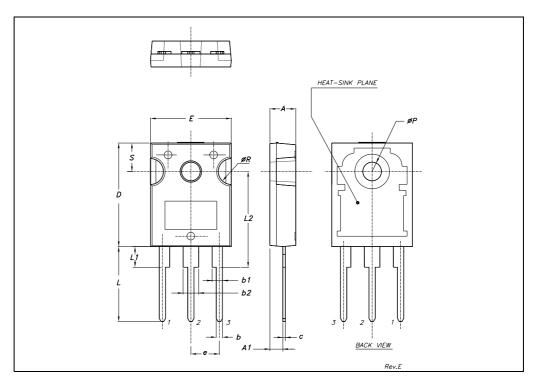
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

11/14

TO-247 MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
С	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
е		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øΡ	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	



STW13NK100Z Revision history

5 Revision history

Table 8. Revision history

Date	Revision	Changes
22-Jun-2004	1	Target document
09-Sep-2004	2	Preliminary document
28-Jan-2005	3	Complete version with curves
18-Sep-2005	4	Figure 12 changed
01-Aug-2006	5	New template, no content change

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